REV	DESCRIPTION	DATE	BY
Α	NEW DRAWING	02/08/05	M. W.
В	UPDATED DWG AND NOTES	09/01/16	JAG



PROBE SPECIFICATIONS

Mechanical Recommen Full Travel: Mechanical Lif e	.050 (1.27) .075 (1.91) 2 x 10 ⁶ cycles				
Operating Tem Consult factor	-55°C to +150°C irements.				
Electrical (Stati Maximum C	•				
Average Probe	< 16mΩ				
Materials and FinishesPlunger:Beryllium over, Gold plated over hard NicBarrel:Brass, Gold plated over hard NickelSpring:Stainless Silver, Silver plated					
Mounting Hole	.067 (1.70) min.				
Spring Force in Preload: Recommen	1.18 (33) 3.25 (92)				

APPLICATIONS

Probes are used in battery charger or electronic device applications such as:

- 1. Camcorders
- 2. Circuit board to board docking stations
- 3. Cellular Phones
- 4. 2-way radios
- 5. Computer docking stations
- 6. Cordless phones
- 7. Chargers
- 8. InkJet Printers
- 9. Notebook and laptop computers
- 10. AC/DC power supplies

BENEFITS AND FEATURES

- 1. Low resistance (average 16 milliohms)
- 2. Better contact than nickel-plated strip contacts
- 3. Maintains high compliancy
- 4. Less susceptible to damage
- 5. Can accommodate up to .025" subsurface battery mating contact
- 6. Longer life than conventional interconnects

Note: Consult factory for higher temperature applications.

ALL DIMENSIONS ARE IN INCHES UNLESS OTHERWISE SPECIFIED								
	EMU	IL/	ATION T	ECHN	OLOGY, INC.			
VLSI and SMT ADAPTERS and ACCESSORIES —								
		741 FLYNN ROAD			TEL: (805) 383-8480			
	C	CAMARILLO, CA 93012		12	FAX: (805) 383-8484			
SHEET:	DATE:		REVISION:	ASSE	MBLY DRAWING			
1 OF 1	02/08/05		В					
CHECKED:			EPARED BY:	ITEM:				
P. MUNROE		M. WILSON		POGO-PIN-8.20-1				
	·				DESCRIPTION:			
DO NOT SCALE DRAWING				POGO-PIN-8.20-1				